

QUALITY . RELIABILITY . PERFORMANCE

QRP Qualatrile Series Nitrile Gloves

Static Decay per FTM 101C, Method 4046 Surface Resistivity per ASTM-D 257 Surface Resistance per ESD S11.11

Request: Test QRP Qualatrile Series Nitrile Gloves using the method Static Decay per FTM 101C, Method 4046 Surface Resistivity per ASTM D-257 Surface Resistance per ESD S11.11

Sample Description: 6 samples of QRP Qualatrile Series Nitrile Gloves were chosen for random testing from the production line.

Method: Per FTM 101C, Method 4046, 3X5-inch test specimens were prepared and conditioned for 49 hours in a humidity control chamber (50% R.H.±2%/23°C)

Test Equipment Utilized:

Resistance Meter: Dr. Thiedig Milli-TO-2 ETS Model 803B Surface/Volume Resistivity Probe ETS Model 809B Calibration Check Fixture Humidity Control Chamber: ETS Model 506A/514 ETS Model 406C Static Decay Meter ETS STM-1 System Test Module

Data Summary:

Static Decay per FTM 101C, Method 4046

ditioning Environment 50% R.H.±2%/23℃	I.C volts	A.C volts	C/O	Decay @ +5kV Seconds	Decay @ -5kV Seconds
	0	5000	10%	0.01	0.01

化乙酰基 防洗 法法理 医磷酸盐酸磷酸盐酸

This document is submitted with the understanding that it is not to be copied or disclosed without the prior written consent of QRP, Inc.

Surface Resistance/Resistivity per FTM 101C, Method 4046

Conditioning Environment 50% R.H. ± 23°C	Minimum	Maximum	Average
Surface Resistance	2.82X10 ⁷	3.16X10 ⁷	2.99X10 ⁷
Surface Resistivity	2.82X10 ⁸	3.16X10 ⁸	2.99X10 ⁸

Commentary:

The QRP Qualatrile Series Nitrile Gloves meet the static decay parameters outlined in FTM 101C, Method 4046, as well as NFPA 99 (which references FTM 4046) with a static decay measurement of 0.02 seconds. The QRP Qualatrile Series Nitrile Glove, with an average measurement of 2.99X10⁸ Ω /sq. qualifies as a static dissipative glove, suitable for use with Class II static sensitive devices. Suitability for use with Class I devices should be decided by the user on an individual basis.

This document is submitted with the understanding that it is not to be copied or disclosed without the prior written consent of QRP, Inc.

QRP, Inc. ©Copyright 1999